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APPLICANTS

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** CONTINUING DATA ***** *None*

** FOREIGN APPLICATIONS *****
 JAPAN 2002-240675 08/21/2002 *OK JL*

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35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	EXAMINER'S SIGNATURE <i>JL</i>	INITIALS <i>JL</i>		

Verified and Acknowledged

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TITLE
 Probe testing method and apparatus for determining acceptable/defective end shape of contact probe through image analysis

FILING FEE RECEIVED 1576	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit
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